

SkyMOS1 N-MOSFET 85V, 3.4mΩ, 120A

Features

- Uses CRM(CQ) advanced SkyMOS1 technology
- Extremely low on-resistance R_{DS(on)}
- Excellent Q_qxR_{DS(on)} product(FOM)
- Qualified according to JEDEC criteria

Product Summary

V_{DS}	85V
R _{DS(on)}	$3.4 m\Omega$
I _D	120A

Applications

- Motor control and drive
- Battery management
- UPS (Uninterrupible Power Supplies)

100% Avalanche Tested



Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRST041N08N	-	TO-220	Tube	N/A	N/A	50pcs
CRSS038N08N	-	TO-263	Tube	N/A	N/A	50pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	85	V
Continuous drain current			
$T_C = 25$ °C (Silicon limit)	I_{D}	172	Α
$T_C = 25$ °C (Package limit)	1 _D	120	Α.
T _C = 100°C (Silicon limit)		109	
Pulsed drain current ($T_C = 25$ °C, t_p limited by T_{jmax})	${ m I}_{ m D\ pulse}$	480	Α
Avalanche energy, single pulse (L=0.5mH, Rg=25 Ω)	E _{AS(Note 1)}	272	mJ
Gate-Source voltage	V_{GS}	±20	V
Power dissipation ($T_C = 25^{\circ}C$)	P _{tot}	208	W
Operating junction and storage temperature	T_j , T_{stg}	-55+150	°C

[%]. Notes:1.EAS is tested at starting Tj = 25°C, L = 0.5mH, IAS = 33A, VGS = 10V. EAS(max)=1089mJ under IAS(max)=66A and above Conditions;





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Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	0.60	°C/W
Thermal resistance, junction – ambient(min. footprint)	R_{thJA}	53] •C/W

Electrical Characteristic (at Tj = 25 °C, unless otherwise specified)

Parameter	Symbol	Value		Heit	Test Condition	
<u> </u>	Symbol	min.	typ.	max.	Unit	rest condition
Static Characteristic						
Drain-source breakdown voltage	BV_{DSS}	85	97	-	V	V _{GS} =0V, I _D =250uA
Gate threshold voltage	V _{GS(th)}	2	3	4	V	$V_{DS}=V_{GS}$, $I_{D}=250$ uA
						V_{DS} =80V, V_{GS} =0V
Zero gate voltage drain current	I_{DSS}	-	0.05	1	μA	T _j =25°C
carrene		-	-	5		T _j =125°C
Gate-source leakage current	I _{GSS}	-	10	100	nA	V _{GS} =±20V,V _{DS} =0V
						$V_{GS} = 10V, I_D = 50A$
Drain-source on-state resistance	R _{DS(on)}	-	3.4	4.1		TO-220
resistance		-	3.2	3.8	mΩ	TO-263
Transconductance	g _{fs}	-	113	-	S	$V_{DS}=5V,I_{D}=40A$

Dynamic Characteristic

Input Capacitance	C_{iss}	-	6050	-		
Output Capacitance	C _{oss}	-	1480	-	pF	$V_{GS} = 0V, V_{DS} = 42.5V,$
Reverse Transfer Capacitance	C_{rss}	-	35	-		f=1MHz
Gate Total Charge	\mathbf{Q}_{G}	ı	74	-		
Gate-Source charge	Q_gs	ı	23	-	nC	V_{GS} =10V, V_{DS} =42.5V, I_{D} =50A, f=1MHz
Gate-Drain charge	Q_{gd}	-	21	-		
Turn-on delay time	t _{d(on)}	ı	32	-		Vds=42.5V
Rise time	t _r	1	53	-	nc	Id=10A
Turn-off delay time	$t_{d(off)}$	-	59	-	ns	Rg= 3.5Ω Vgs= $10V$;
Fall time	t _f	-	34	-		(Note 2,3)
Gate resistance	R_G	-	3.3	-	Ω	V _{GS} =0V, V _{DS} =0V, f=1MHz





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Body Diode Characteristic

Parameter	Symbol		Value	Value		Test Condition	
	Syllibol	min.	typ.	max.	Unit	rest condition	
Body Diode Forward Voltage	V_{SD}	1	0.9	1.4	>	V _{GS} =0V,I _{SD} =50A	
Body Diode Reverse Recovery Time	t _{rr}	-	76	-	ns	IS=30A, VGS=0V,	
Body Diode Reverse Recovery Charge	Q_{rr}	1	97	-	nC	dIF/dt=100A/us;	

^{※.} Notes



^{2.}Pulse Test : Pulse Width \leq 300us, duty cycle \leq 2%.

^{3.} Essentially independent of operating temperature.

Typical Performance Characteristics

Fig 1: Output Characteristics 400 Notes: Vss=9V.10V 1. 250µs Pulse Test From Bottom To Top 2. T=25 T 300 VBs=7V 200 Vgs=6V 100 Vos=5V 0 12 Vos, Drain To Source Voltage (V)

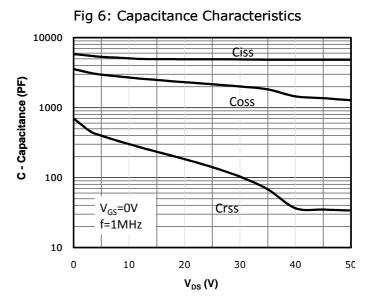
Fig 2: Transfer Characteristics 400 Vps=5V Tj=25 °C Drain Current (A) 300 200 T₁=125°C 100 0 3 4 5 6 8 9 10 Gate To Source Voltage (V)

Fig 3: Rds(on) vs Drain Current and Gate Voltage 7.0 6.0 R_{DS(on)} (mΩ) 5.0 V_{GS}=10V 4.0 3.0 2.0 10 40 100 20 30 50 60 70 80 90 $I_D(A)$

Fig 4: Rds(on) vs Gate Voltage

10⁰
10⁻¹
10⁻²
10⁻³
2
4
6
8
10
V_{es}(V)

Fig 5: Rds(on) vs. Temperature 2.4 $V_{GS}=10V$ 2.2 $I_D = 50A$ 2.0 R_{DS(on)}_Normalized 1.8 1.6 1.4 1.2 1.0 0.8 0.6 0.4 25 150 175 Tj - Junction Temperature (°C)





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Fig 7: Gate Charge Characteristics

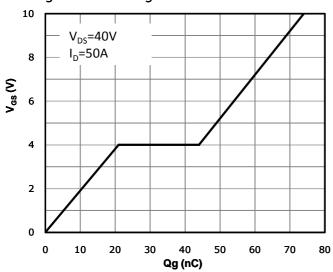


Fig 8: Body-diode Forward Characteristics

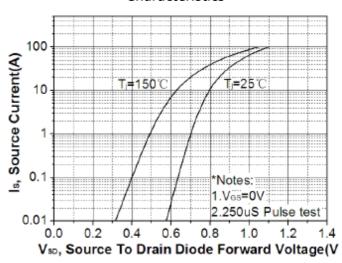


Fig 9: Power Dissipation

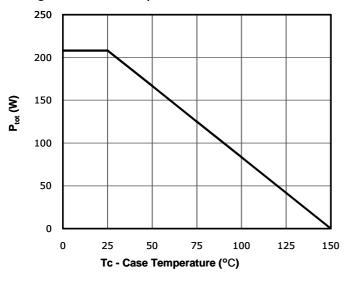


Fig 10: Drain Current Derating

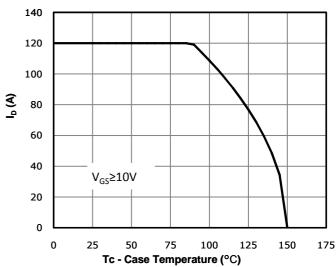


Fig 11: Safe Operating Area

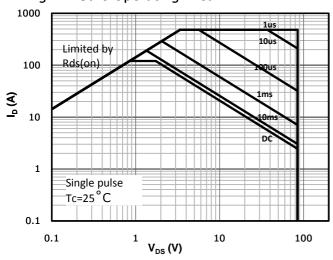
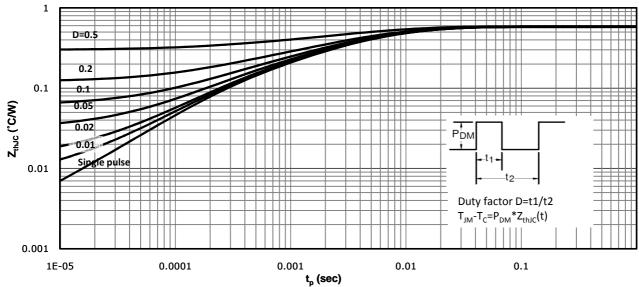




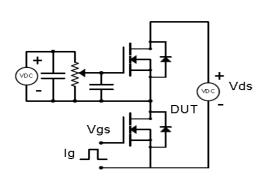
Fig 12: Max. Transient Thermal Impedance

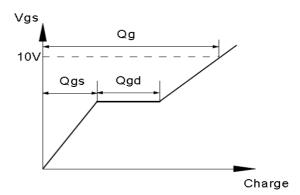




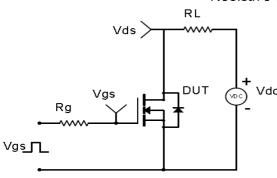
Test Circuit & Waveform

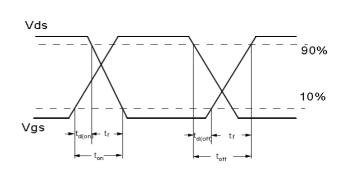
Gate Charge Test Circuit & Waveform



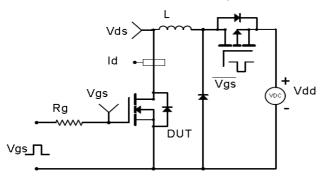


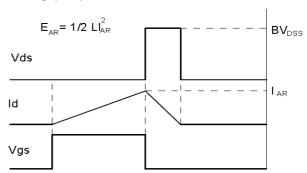
Resistive Switching Test Circuit & Waveforms



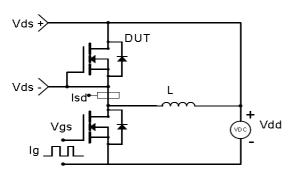


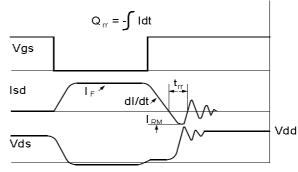
Unclamped Inductive Switching (UIS) Test Circuit & Waveforms





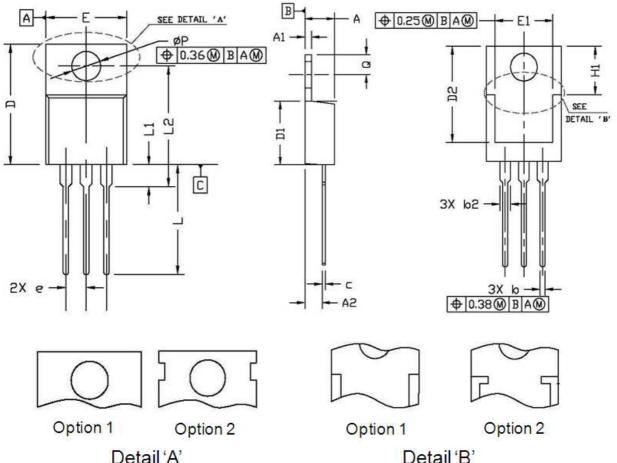
Diode Recovery Test Circuit & Waveforms







Package Outline: TO-220-3L

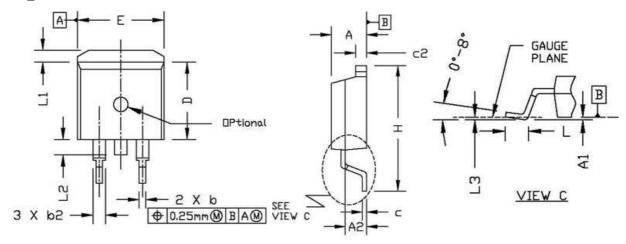


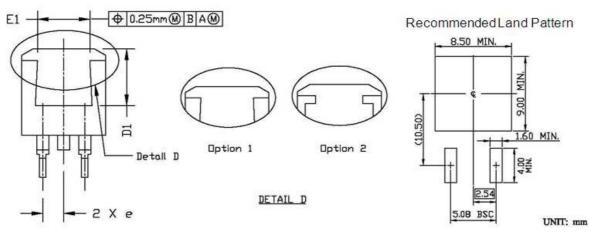
Detail	·A			Deta	III.B
	_	 			_

Sumbal	Dimensions I	n Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
А	4.30	4.80	0.169	0.189
A1	1.20	1.45	0.047	0.057
A2	2.20	2.90	0.087	0.114
b	0.69	0.95	0.027	0.037
b2	1.00	1.60	0.039	0.063
С	0.33	0.65	0.013	0.026
D	14.70	16.20	0.579	0.638
D1	8.59	9.65	0.338	0.380
D2	11.75	13.60	0.463	0.535
е	2.54	BSC.	0.100) BSC.
Е	9.60	10.60	0.378	0.417
E1	7.00	8.46	0.276	0.333
H1	6.20	7.00	0.244	0.276
L	12.60	14.80	0.496	0.583
L1	2.70	3.80	0.106	0.150
L2	12.13	16.50	0.478	0.650
Q	2.40	3.10	0.094	0.122
Р	3.50	3.90	0.138	0.154



Package Outline: TO-263





Cumbal	Dimensions I	in Millimeters	Dimension	s In Inches
Symbol	Min.	Max.	Min.	Max.
Α	4.30	4.86	0.169	0.191
A1	0.00	0.25	0.000	0.010
A2	2.34	2.79	0.092	0.110
b	0.68	0.94	0.027	0.037
b2	1.15	1.35	0.045	0.053
С	0.33	0.65	0.013	0.026
c2	1.17	1.40	0.046	0.055
D	8.38	9.45	0.330	0.372
D1	6.90	8.17	0.272	0.322
е	2.54	BSC.	0.10	0 BSC.
Е	9.78	10.50	0.385	0.413
E1	6.50	8.60	0.256	0.339
Н	14.61	15.88	0.575	0.625
L	2.24	3.00	0.088	0.118
L1	0.70	1.60	0.028	0.063
L2	1.00	1.78	0.039	0.070
L3	0.00	0.25	0.000	0.010





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Revision History

Revison	Date	Major changes
1.0	2018-02-09	Release of formal version.
2.0	2019-05-27	Supplement package outline info.

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qulified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semicondutor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM(CQ) reserves the right to improve product design, function and reliability without notice.

